

Search Notes

Application/Control No.

10/564,396

Examiner

Benny Lee

Applicant(s)/Patent under
Reexamination

TAE ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
333	156,161	10/22/2007	BTL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR